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Details

Product Status	Active
Core Processor	12V1
Core Size	16-Bit
Speed	25MHz
Connectivity	CANbus, IrDA, LINbus, SCI, SPI
Peripherals	LVD, POR, PWM, WDT
Number of I/O	54
Program Memory Size	128KB (128K x 8)
Program Memory Type	FLASH
EEPROM Size	4K x 8
RAM Size	8K x 8
Voltage - Supply (Vcc/Vdd)	3.13V ~ 5.5V
Data Converters	A/D 12x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	64-LQFP
Supplier Device Package	64-LQFP (10x10)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/s9s12g128avlh

Chapter 9

Security (S12XS9SECV2)

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Chapter 10

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- Bus-off recovery by software intervention or automatically
- 16-bit time stamp of transmitted/received messages

1.3.12 Serial Communication Interface Module (SCI)

- Up to three SCI modules
- Full-duplex or single-wire operation
- Standard mark/space non-return-to-zero (NRZ) format
- Selectable IrDA 1.4 return-to-zero-inverted (RZI) format with programmable pulse widths
- 13-bit baud rate selection
- Programmable character length
- Programmable polarity for transmitter and receiver
- Active edge receive wakeup
- Break detect and transmit collision detect supporting LIN 1.3, 2.0, 2.1 and SAE J2602

1.3.13 Serial Peripheral Interface Module (SPI)

- Up to three SPI modules
- Configurable 8- or 16-bit data size
- Full-duplex or single-wire bidirectional
- Double-buffered transmit and receive
- Master or slave mode
- MSB-first or LSB-first shifting
- Serial clock phase and polarity options

1.3.14 Analog-to-Digital Converter Module (ADC)

Up to 16-channel, 10-bit/12-bit¹ analog-to-digital converter

- 3 μ s conversion time
- 8-/10¹-bit resolution
- Left or right justified result data
- Wakeup from low power modes on analog comparison > or <= match
- Continuous conversion mode
- External triggers to initiate conversions via GPIO or peripheral outputs such as PWM or TIM
- Multiple channel scans
- Precision fixed voltage reference for ADC conversions
-
- Pins can also be used as digital I/O including wakeup capability

1. 12-bit resolution only available on S12GA192 and S12GA240 devices.

1.8.7 S12GA96 and S12GA128

1.8.7.1 Pinout 48-Pin LQFP

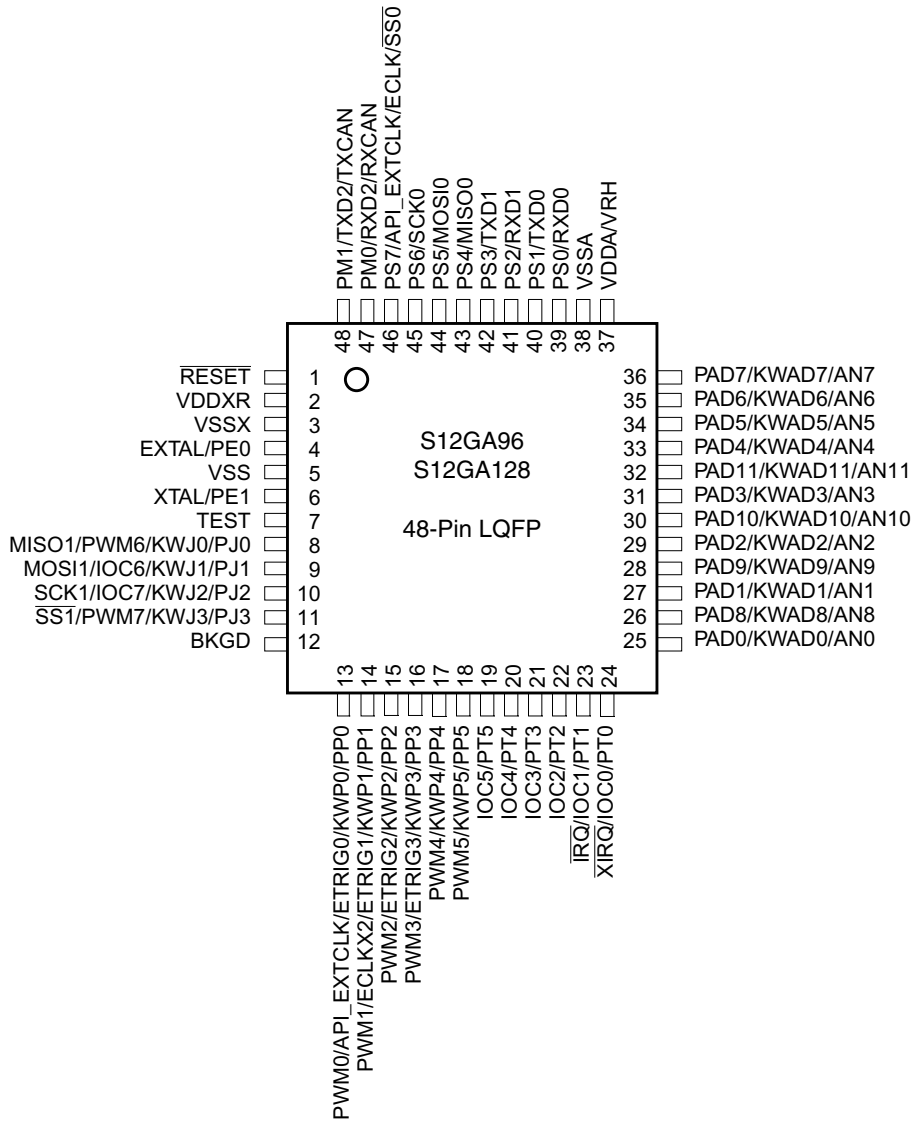


Figure 1-18. 48-Pin LQFP Pinout for S12GA96 and S12GA128

Table 1-23. 48-Pin LQFP Pinout for S12GA96 and S12GA128

Package Pin	Pin	Function <----lowest-----PRIORITY-----highest---->				Power Supply	Internal Pull Resistor	
		2nd Func.	3rd Func.	4th Func	5th Func		CTRL	Reset State
1	RESET	—	—	—	—	V _{DDX}	PULLUP	

Table 1-37. Initial WCOP Configuration

NV[3] in FOPT Register	WCOP in CPMUCOP Register
1	0
0	1

1.14 Autonomous Clock (ACLK) Configuration

The autonomous clock¹ (ACLK) is not factory trimmed. The reset value of the autonomous clock trimming register² (CPMUACLKTR) is 0xFC.

1.15 ADC External Trigger Input Connection

The ADC module includes external trigger inputs ETRIG0, ETRIG1, ETRIG2, and ETRIG3. The external trigger allows the user to synchronize ADC conversion to external trigger events. [Chapter 2, “Port Integration Module \(S12GPIMV1\)”](#) describes the connection of the external trigger inputs. Consult the ADC section for information about the analog-to-digital converter module. References to freeze mode are equivalent to active BDM mode.

1.16 ADC Special Conversion Channels

Whenever the ADC’s Special Channel Conversion Bit (SC) is set, it is capable of running conversion on a number of internal channels (see [Table 13-15](#)). [Table 1-38](#) lists the internal reference voltages which are connected to these special conversion channels.

Table 1-38. Usage of ADC Special Conversion Channels

ADC Channel	Usage
Internal_0	V _{DDF} ¹
Internal_1	unused
Internal_2	unused
Internal_3	unused
Internal_4	unused
Internal_5	unused
Internal_6	unused
	Temperature sense of ADC hardmacro ²
Internal_7	unused

¹ See [Section 1.17, “ADC Result Reference”](#).

² The ADC temperature sensor is only available on S12GA192 and S12GA240 devices.

1. See [Chapter 10, “S12 Clock, Reset and Power Management Unit \(S12CPMU\)”](#)

2. See [Section 10.3.2.15, “Autonomous Clock Trimming Register \(CPMUACLKTR\)”](#)

Table 2-46. PRR0 Register Field Descriptions

Field	Description
7 PRR0P3	Pin Routing Register PWM3 —Select alternative routing of PWM3 output, ETRIG3 input This bit programs the routing of the PWM3 channel and the ETRIG3 input to a different external pin in 20 TSSOP. See Table 2-47 for more details.
6 PRR0P2	Pin Routing Register PWM2 —Select alternative routing of PWM2 output, ETRIG2 input This bit programs the routing of the PWM2 channel and the ETRIG2 input to a different external pin in 20 TSSOP. See Table 2-48 for more details.
5 PRR0T31	Pin Routing Register IOC3 —Select alternative routing of IOC3 output and input Those two bits program the routing of the timer IOC3 channel to different external pins in 20 TSSOP. See Table 2-49 for more details.
4 PRR0T30	
3 PRR0T21	Pin Routing Register IOC2 —Select alternative routing of IOC2 output and input Those two bits program the routing of the timer IOC2 channel to different external pins in 20 TSSOP. See Table 2-50 for more details.
2 PRR0T20	
1 PRR0S1	Pin Routing Register Serial Module —Select alternative routing of SCI0 pins Those bits program the routing of the SCI0 module pins to different external pins in 20 TSSOP. See Table 2-51 for more details.
0 PRR0S0	

Table 2-47. PWM3/ETRIG3 Routing Options

PRR0P3	PWM3/ETRIG3 Associated Pin
0	PS7 - PWM3, ETRIG3
1	PAD5 - PWM3, ETRIG3

Table 2-48. PWM2/ETRIG2 Routing Options

PRR0P2	PWM2/ETRIG2 Associated Pin
0	PS4 - PWM2, ETRIG2
1	PAD4 - PWM2, ETRIG2

Table 2-49. IOC3 Routing Options

PRR0T31	PRR0T30	IOC3 Associated Pin
0	0	PS6 - IOC3
0	1	PE1 - IOC3
1	0	PAD5 - IOC3
1	1	Reserved

Both interrupts are capable to wake-up the device from stop mode. Means for glitch filtering are not provided on these pins.

2.5.4.2 Pin Interrupts and Wakeup

Ports P, J and AD offer pin interrupt capability. The related interrupt enable (PIE) as well as the sensitivity to rising or falling edges (PPS) can be individually configured on per-pin basis. All bits/pins in a port share the same interrupt vector. Interrupts can be used with the pins configured as inputs or outputs.

An interrupt is generated when a port interrupt flag (PIF) and its corresponding port interrupt enable (PIE) are both set. The pin interrupt feature is also capable to wake up the CPU when it is in stop or wait mode.

A digital filter on each pin prevents short pulses from generating an interrupt. A valid edge on an input is detected if 4 consecutive samples of a passive level are followed by 4 consecutive samples of an active level. Else the sampling logic is restarted.

In run and wait mode the filters are continuously clocked by the bus clock. Pulses with a duration of $t_{PULSE} < n_{P_MASK}/f_{bus}$ are assuredly filtered out while pulses with a duration of $t_{PULSE} > n_{P_PASS}/f_{bus}$ guarantee a pin interrupt.

In stop mode the clock is generated by an RC-oscillator. The minimum pulse length varies over process conditions, temperature and voltage (Figure 2-65). Pulses with a duration of $t_{PULSE} < t_{P_MASK}$ are assuredly filtered out while pulses with a duration of $t_{PULSE} > t_{P_PASS}$ guarantee a wakeup event.

Please refer to the appendix table “Pin Interrupt Characteristics” for pulse length limits.

To maximize current saving the RC oscillator is active only if the following condition is true on any individual pin:

Sample count ≤ 4 (at active or passive level) and interrupt enabled (PIE=1) and interrupt flag not set (PIF=0).

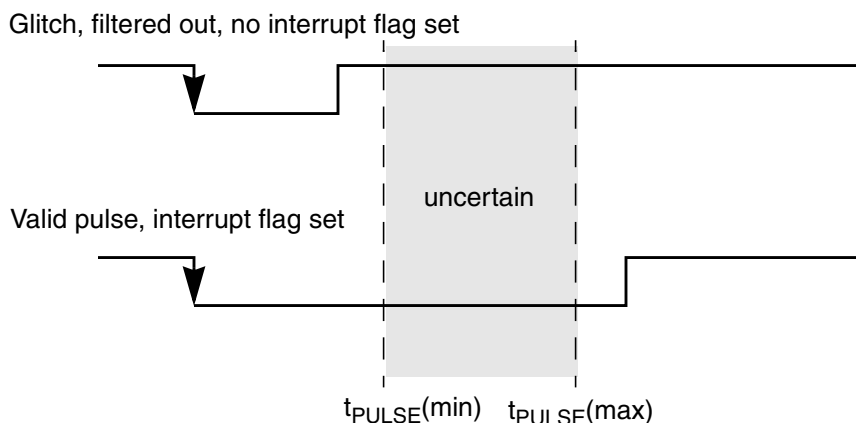


Figure 2-65. Interrupt Glitch Filter (here: active low level selected)

Table 3-3. ACMP5 Register Field Descriptions

Field	Description
7 ACIF	<p>ACMP Interrupt Flag— ACIF is set when a compare event occurs. Compare events are defined by ACMOD[1:0]. Writing a logic “1” to the bit field clears the flag.</p> <p>0 Compare event has not occurred 1 Compare event has occurred</p>
6 ACO	<p>ACMP Output— Reading ACO returns the current value of the synchronized ACMP output. Refer to ACE description to account for initialization delay on this path.</p>

3.7 Functional Description

The ACMP compares two analog input voltages applied to ACMPPM and ACMPP. The comparator output is high when the voltage at the non-inverting input is greater than the voltage at the inverting input, and is low when the non-inverting input voltage is lower than the inverting input voltage.

The ACMP is enabled with register bit ACMPC[ACE]. When ACMPC[ACE] is set, the input pins are connected to low-pass filters. The comparator output is disconnected from the subsequent logic, which is held at its state for 63 bus clock cycles after setting ACMPC[ACE] to “1” to mask potential glitches. This initialization delay must be accounted for before the first comparison result can be expected.

The initial hold state after reset is zero, thus if input voltages are set to result in “true” result ($V_{ACMPP} > V_{ACMPM}$) before the initialization delay has passed, a flag will be set immediately after this.

Similarly the flag will also be set when disabling the ACMP, then re-enabling it with the inputs changing to produce an opposite result to the hold state before the end of the initialization delay.

By setting the ACMPC[ACICE] bit the gated comparator output can be connected to the synchronized timer input capture channel 5 (see [Figure 3-1](#)). This feature can be used to generate time stamps and timer interrupts on ACMP events.

The comparator output signal synchronized to the bus clock is used to read the comparator output status (ACMPS[ACO]) and to set the interrupt flag (ACMPS[ACIF]).

The condition causing the interrupt flag (ACMPS[ACIF]) to assert is selected with register bits ACMPC[ACMOD1:ACMOD0]. This includes any edge configuration, that is rising, or falling, or rising and falling (toggle) edges of the comparator output. Also flag setting can be disabled.

An interrupt will be generated if the interrupt enable bit (ACMPC[ACIE]) and the interrupt flag (ACMPS[ACIF]) are both set. ACMPS[ACIF] is cleared by writing a 1.

The raw comparator output signal ACMPO can be driven out on an external pin by setting the ACMPC[ACOPE] bit.

10.4 Functional Description

10.4.1 Phase Locked Loop with Internal Filter (PLL)

The PLL is used to generate a high speed PLLCLK based on a low frequency REFCLK.

The REFCLK is by default the IRCCLK which is trimmed to $f_{IRC1M_TRIM}=1\text{MHz}$.

If using the oscillator (OSCE=1) REFCLK will be based on OSCCLK. For increased flexibility, OSCCLK can be divided in a range of 1 to 16 to generate the reference frequency REFCLK using the REFDIV[3:0] bits. Based on the SYNDIV[5:0] bits the PLL generates the VCOCLK by multiplying the reference clock by a 2, 4, 6,... 126, 128. Based on the POSTDIV[4:0] bits the VCOCLK can be divided in a range of 1,2, 3, 4, 5, 6,... to 32 to generate the PLLCLK.

$$\text{If oscillator is enabled (OSCE=1)} \quad f_{REF} = \frac{f_{OSC}}{(REFDIV + 1)}$$

$$\text{If oscillator is disabled (OSCE=0)} \quad f_{REF} = f_{IRC1M}$$

$$f_{VCO} = 2 \times f_{REF} \times (SYNDIV + 1)$$

$$\text{If PLL is locked (LOCK=1)} \quad f_{PLL} = \frac{f_{VCO}}{(POSTDIV + 1)}$$

$$\text{If PLL is not locked (LOCK=0)} \quad f_{PLL} = \frac{f_{VCO}}{4}$$

$$\text{If PLL is selected (PLLSEL=1)} \quad f_{bus} = \frac{f_{PLL}}{2}$$

NOTE

Although it is possible to set the dividers to command a very high clock frequency, do not exceed the specified bus frequency limit for the MCU.

Several examples of PLL divider settings are shown in [Table 10-25](#). The following rules help to achieve optimum stability and shortest lock time:

- Use lowest possible f_{VCO} / f_{REF} ratio (SYNDIV value).
- Use highest possible REFCLK frequency f_{REF} .

Table 10-25. Examples of PLL Divider Settings

f_{osc}	REFDIV[3:0]	f_{REF}	REFFRQ[1:0]	SYNDIV[5:0]	f_{VCO}	VCOFRQ[1:0]	POSTDIV [4:0]	f_{PLL}	f_{bus}
off	\$00	1MHz	00	\$18	50MHz	01	\$03	12.5MHz	6.25MHz

Table 16-5. External Trigger Channel Select Coding

ETRIGSEL	ETRIGCH3	ETRIGCH2	ETRIGCH1	ETRIGCH0	External trigger source is
0	0	0	0	0	AN0
0	0	0	0	1	AN1
0	0	0	1	0	AN2
0	0	0	1	1	AN3
0	0	1	0	0	AN4
0	0	1	0	1	AN5
0	0	1	1	0	AN6
0	0	1	1	1	AN7
0	1	0	0	0	AN8
0	1	0	0	1	AN9
0	1	0	1	0	AN10
0	1	0	1	1	AN11
0	1	1	0	0	AN12
0	1	1	0	1	AN13
0	1	1	1	0	AN14
0	1	1	1	1	AN15
1	0	0	0	0	ETRIG0 ¹
1	0	0	0	1	ETRIG1 ¹
1	0	0	1	0	ETRIG2 ¹
1	0	0	1	1	ETRIG3 ¹
1	0	1	X	X	Reserved
1	1	X	X	X	Reserved

¹ Only if ETRIG3-0 input option is available (see device specification), else ETRISEL is ignored, that means external trigger source is still on one of the AD channels selected by ETRIGCH3-0

16.3.2.3 ATD Control Register 2 (ATDCTL2)

Writes to this register will abort current conversion sequence.

Module Base + 0x0002

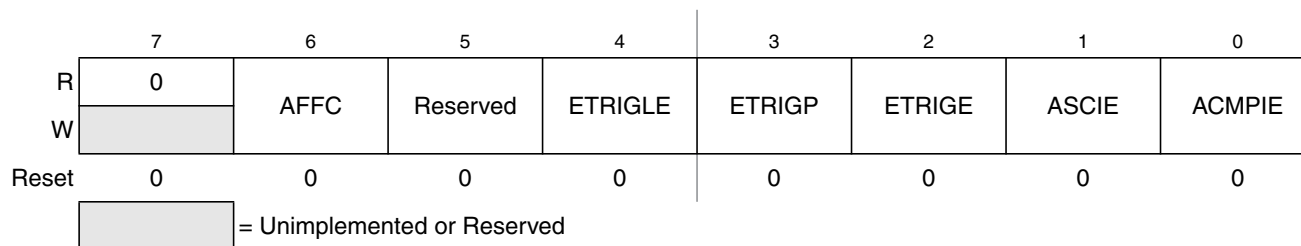


Figure 16-5. ATD Control Register 2 (ATDCTL2)

Read: Anytime

Write: Anytime

19.3 Memory Map and Register Definition

19.3.1 Module Memory Map

This section describes the content of the registers in the scalable PWM module. The base address of the scalable PWM module is determined at the MCU level when the MCU is defined. The register decode map is fixed and begins at the first address of the module address offset. The figure below shows the registers associated with the scalable PWM and their relative offset from the base address. The register detail description follows the order they appear in the register map.

Reserved bits within a register will always read as 0 and the write will be unimplemented. Unimplemented functions are indicated by shading the bit.

NOTE

Register Address = Base Address + Address Offset, where the Base Address is defined at the MCU level and the Address Offset is defined at the module level.

19.3.2 Register Descriptions

This section describes in detail all the registers and register bits in the scalable PWM module.

Register Name		Bit 7	6	5	4	3	2	1	Bit 0
0x0000 PWME ¹	R W	PWME7	PWME6	PWME5	PWME4	PWME3	PWME2	PWME1	PWME0
0x0001 PPOL ¹	R W	PPOL7	PPOL6	PPOL5	PPOL4	PPOL3	PPOL2	PPOL1	PPOL0
0x0002 PCLK ¹	R W	PCLK7	PCLK6	PCLK5	PCLK4	PCLK3	PCLK2	PCLK1	PCLK0
0x0003 PCKB ¹	R W	0	PCKB2	PCKB1	PCKB0	0	PCKA2	PCKA1	PCKA0
0x0004 PWCAE ¹	R W	CAE7	CAE6	CAE5	CAE4	CAE3	CAE2	CAE1	CAE0
0x0005 PWC ¹	R W	CON67	CON45	CON23	CON01	PSWAI	PFRZ	0	0
0x0006 PCLKAB ¹	R W	PCLKAB7	PCLKAB6	PCLKAB5	PCLKAB4	PCLKAB3	PCLKAB2	PCLKAB1	PCLKAB0


 = Unimplemented or Reserved

Figure 19-2. The scalable PWM Register Summary (Sheet 1 of 4)

23.3.2 Register Descriptions

This section consists of register descriptions in address order. Each description includes a standard register diagram with an associated figure number. Details of register bit and field function follow the register diagrams, in bit order.

Only bits related to implemented channels are valid.

Register Name		Bit 7	6	5	4	3	2	1	Bit 0
0x0000 TIOS	R W	IOS7	IOS6	IOS5	IOS4	IOS3	IOS2	IOS1	IOS0
0x0001 CFORC	R W	0	0	0	0	0	0	0	0
0x0002 OC7M	R W	OC7M7	OC7M6	OC7M5	OC7M4	OC7M3	OC7M2	OC7M1	OC7M0
0x0003 OC7D	R W	OC7D7	OC7D6	OC7D5	OC7D4	OC7D3	OC7D2	OC7D1	OC7D0
0x0004 TCNTH	R W	TCNT15	TCNT14	TCNT13	TCNT12	TCNT11	TCNT10	TCNT9	TCNT8
0x0005 TCNTL	R W	TCNT7	TCNT6	TCNT5	TCNT4	TCNT3	TCNT2	TCNT1	TCNT0
0x0006 TSCR1	R W	TEN	TSWAI	TSFRZ	TFFCA	PRNT	0	0	0
0x0007 TTOV	R W	TOV7	TOV6	TOV5	TOV4	TOV3	TOV2	TOV1	TOV0
0x0008 TCTL1	R W	OM7	OL7	OM6	OL6	OM5	OL5	OM4	OL4
0x0009 TCTL2	R W	OM3	OL3	OM2	OL2	OM1	OL1	OM0	OL0
0x000A TCTL3	R W	EDG7B	EDG7A	EDG6B	EDG6A	EDG5B	EDG5A	EDG4B	EDG4A
0x000B TCTL4	R W	EDG3B	EDG3A	EDG2B	EDG2A	EDG1B	EDG1A	EDG0B	EDG0A
0x000C TIE	R W	C7I	C6I	C5I	C4I	C3I	C2I	C1I	C0I
0x000D TSCR2	R W	TOI	0	0	0	TCRE	PR2	PR1	PR0
0x000E TFLG1	R W	C7F	C6F	C5F	C4F	C3F	C2F	C1F	C0F
0x000F TFLG2	R W	TOF	0	0	0	0	0	0	0
0x0010–0x001F TCxH–TCxL ¹	R W	Bit 15	Bit 14	Bit 13	Bit 12	Bit 11	Bit 10	Bit 9	Bit 8
	R W	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
0x0020 PACTL	R W	0	PAEN	PAMOD	PEDGE	CLK1	CLK0	PAOVI	PAI

Figure 23-5. TIM16B8CV3 Register Summary (Sheet 1 of 2)

24.4.4.3 Valid Flash Module Commands

Table 24-25 present the valid Flash commands, as enabled by the combination of the functional MCU mode (Normal SingleChip NS, Special Singlechip SS) with the MCU security state (Unsecured, Secured).

Special Singlechip mode is selected by input mmc_ss_mode_ts2 asserted. MCU Secured state is selected by input mmc_secure input asserted.

Table 24-25. Flash Commands by Mode and Security State

FCMD	Command	Unsecured		Secured	
		NS ¹	SS ²	NS ³	SS ⁴
0x01	Erase Verify All Blocks	*	*	*	*
0x02	Erase Verify Block	*	*	*	*
0x03	Erase Verify P-Flash Section	*	*	*	
0x04	Read Once	*	*	*	
0x06	Program P-Flash	*	*	*	
0x07	Program Once	*	*	*	
0x08	Erase All Blocks		*		*
0x09	Erase Flash Block	*	*	*	
0x0A	Erase P-Flash Sector	*	*	*	
0x0B	Unsecure Flash		*		*
0x0C	Verify Backdoor Access Key	*		*	
0x0D	Set User Margin Level	*	*	*	
0x0E	Set Field Margin Level		*		
0x10	Erase Verify EEPROM Section	*	*	*	
0x11	Program EEPROM	*	*	*	
0x12	Erase EEPROM Sector	*	*	*	

¹ Unsecured Normal Single Chip mode

² Unsecured Special Single Chip mode.

³ Secured Normal Single Chip mode.

⁴ Secured Special Single Chip mode.

24.4.4.4 P-Flash Commands

Table 24-26 summarizes the valid P-Flash commands along with the effects of the commands on the P-Flash block and other resources within the Flash module.

Table 24-26. P-Flash Commands

FCMD	Command	Function on P-Flash Memory
0x01	Erase Verify All Blocks	Verify that all P-Flash (and EEPROM) blocks are erased.



Table 26-16. FERSTAT Field Descriptions

Field	Description
1 DFDIF	Double Bit Fault Detect Interrupt Flag — The setting of the DFDIF flag indicates that a double bit fault was detected in the stored parity and data bits during a Flash array read operation or that a Flash array read operation returning invalid data was attempted on a Flash block that was under a Flash command operation. ¹ The DFDIF flag is cleared by writing a 1 to DFDIF. Writing a 0 to DFDIF has no effect on DFDIF. ² 0 No double bit fault detected 1 Double bit fault detected or a Flash array read operation returning invalid data was attempted while command running
0 SFDIF	Single Bit Fault Detect Interrupt Flag — With the IGNSF bit in the FCNFG register clear, the SFDIF flag indicates that a single bit fault was detected in the stored parity and data bits during a Flash array read operation or that a Flash array read operation returning invalid data was attempted on a Flash block that was under a Flash command operation. ¹ The SFDIF flag is cleared by writing a 1 to SFDIF. Writing a 0 to SFDIF has no effect on SFDIF. 0 No single bit fault detected 1 Single bit fault detected and corrected or a Flash array read operation returning invalid data was attempted while command running

¹ The single bit fault and double bit fault flags are mutually exclusive for parity errors (an ECC fault occurrence can be either single fault or double fault but never both). A simultaneous access collision (Flash array read operation returning invalid data attempted while command running) is indicated when both SFDIF and DFDIF flags are high.

² There is a one cycle delay in storing the ECC DFDIF and SFDIF fault flags in this register. At least one NOP is required after a flash memory read before checking FERSTAT for the occurrence of ECC errors.

26.3.2.9 P-Flash Protection Register (FPROT)

The FPROT register defines which P-Flash sectors are protected against program and erase operations.

Offset Module Base + 0x0008

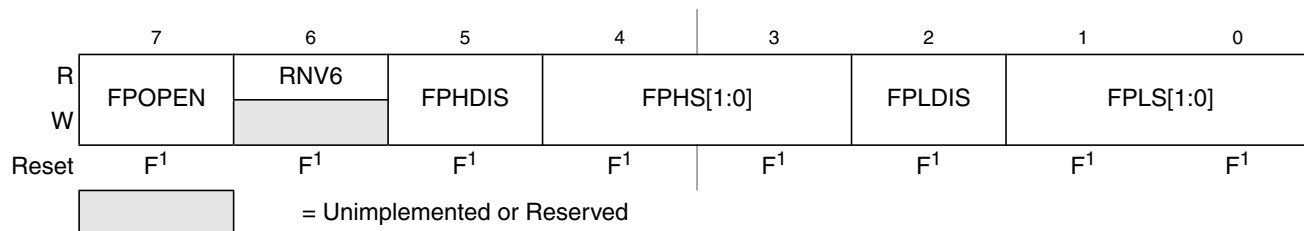


Figure 26-13. Flash Protection Register (FPROT)

¹ Loaded from IFR Flash configuration field, during reset sequence.

The (unreserved) bits of the FPROT register are writable with the restriction that the size of the protected region can only be increased (see [Section 26.3.2.9.1, “P-Flash Protection Restrictions,”](#) and [Table 26-21](#)).

During the reset sequence, the FPROT register is loaded with the contents of the P-Flash protection byte in the Flash configuration field at global address 0x3_FF0C located in P-Flash memory (see [Table 26-4](#)) as indicated by reset condition ‘F’ in [Figure 26-13](#). To change the P-Flash protection that will be loaded during the reset sequence, the upper sector of the P-Flash memory must be unprotected, then the P-Flash protection byte must be reprogrammed. If a double bit fault is detected while reading the P-Flash phrase containing the P-Flash protection byte during the reset sequence, the FPOpen bit will be cleared and remaining bits in the FPROT register will be set to leave the P-Flash memory fully protected.

8. Reset the MCU

26.5.3 Mode and Security Effects on Flash Command Availability

The availability of Flash module commands depends on the MCU operating mode and security state as shown in [Table 26-27](#).

26.6 Initialization

On each system reset the flash module executes an initialization sequence which establishes initial values for the Flash Block Configuration Parameters, the FPROT and EEPROT protection registers, and the FOPT and FSEC registers. The initialization routine reverts to built-in default values that leave the module in a fully protected and secured state if errors are encountered during execution of the reset sequence. If a double bit fault is detected during the reset sequence, both MGSTAT bits in the FSTAT register will be set.

CCIF is cleared throughout the initialization sequence. The Flash module holds off all CPU access for a portion of the initialization sequence. Flash reads are allowed once the hold is removed. Completion of the initialization sequence is marked by setting CCIF high which enables user commands.

If a reset occurs while any Flash command is in progress, that command will be immediately aborted. The state of the word being programmed or the sector/block being erased is not guaranteed.

30.4.6.15 Program EEPROM Command

The Program EEPROM operation programs one to four previously erased words in the EEPROM block. The Program EEPROM operation will confirm that the targeted location(s) were successfully programmed upon completion.

CAUTION

A Flash word must be in the erased state before being programmed.
Cumulative programming of bits within a Flash word is not allowed.

Table 30-62. Program EEPROM Command FCCOB Requirements

CCOBIX[2:0]	FCCOB Parameters	
000	0x11	Global address [17:16] to identify the EEPROM block
001	Global address [15:0] of word to be programmed	
010	Word 0 program value	
011	Word 1 program value, if desired	
100	Word 2 program value, if desired	
101	Word 3 program value, if desired	

Upon clearing CCIF to launch the Program EEPROM command, the user-supplied words will be transferred to the Memory Controller and be programmed if the area is unprotected. The CCOBIX index value at Program EEPROM command launch determines how many words will be programmed in the EEPROM block. The CCIF flag is set when the operation has completed.

Table 30-63. Program EEPROM Command Error Handling

Register	Error Bit	Error Condition
FSTAT	ACCERR	Set if CCOBIX[2:0] < 010 at command launch
		Set if CCOBIX[2:0] > 101 at command launch
		Set if command not available in current mode (see Table 30-27)
		Set if an invalid global address [17:0] is supplied
		Set if a misaligned word address is supplied (global address [0] != 0)
		Set if the requested group of words breaches the end of the EEPROM block
	FPVIOL	Set if the selected area of the EEPROM memory is protected
	MGSTAT1	Set if any errors have been encountered during the verify operation
	MGSTAT0	Set if any non-correctable errors have been encountered during the verify operation

30.4.6.16 Erase EEPROM Sector Command

The Erase EEPROM Sector operation will erase all addresses in a sector of the EEPROM block.

P-Flash memory (see [Table 31-4](#)) as indicated by reset condition F in [Table 31-23](#). To change the EEPROM protection that will be loaded during the reset sequence, the P-Flash sector containing the EEPROM protection byte must be unprotected, then the EEPROM protection byte must be programmed. If a double bit fault is detected while reading the P-Flash phrase containing the EEPROM protection byte during the reset sequence, the DPOPEN bit will be cleared and DPS bits will be set to leave the EEPROM memory fully protected.

Trying to alter data in any protected area in the EEPROM memory will result in a protection violation error and the FPVIOL bit will be set in the FSTAT register. Block erase of the EEPROM memory is not possible if any of the EEPROM sectors are protected.

Table 31-22. EEPROT Field Descriptions

Field	Description
7 DPOPEN	EEPROM Protection Control 0 Enables EEPROM memory protection from program and erase with protected address range defined by DPS bits 1 Disables EEPROM memory protection from program and erase
6–0 DPS[6:0]	EEPROM Protection Size — The DPS[6:0] bits determine the size of the protected area in the EEPROM memory, this size increase in step of 32 bytes, as shown in Table 31-23 .

Table 31-23. EEPROM Protection Address Range

DPS[6:0]	Global Address Range	Protected Size
0000000	0x0_0400 – 0x0_041F	32 bytes
0000001	0x0_0400 – 0x0_043F	64 bytes
0000010	0x0_0400 – 0x0_045F	96 bytes
0000011	0x0_0400 – 0x0_047F	128 bytes
0000100	0x0_0400 – 0x0_049F	160 bytes
0000101	0x0_0400 – 0x0_04BF	192 bytes
The Protection Size goes on enlarging in step of 32 bytes, for each DPS value increasing of one. . . .		
1111111	0x0_0400 – 0x0_13FF	4,096 bytes

31.3.2.11 Flash Common Command Object Register (FCCOB)

The FCCOB is an array of six words addressed via the CCOBIX index found in the FCCOBIX register. Byte wide reads and writes are allowed to the FCCOB register.

Offset Module Base + 0x000A

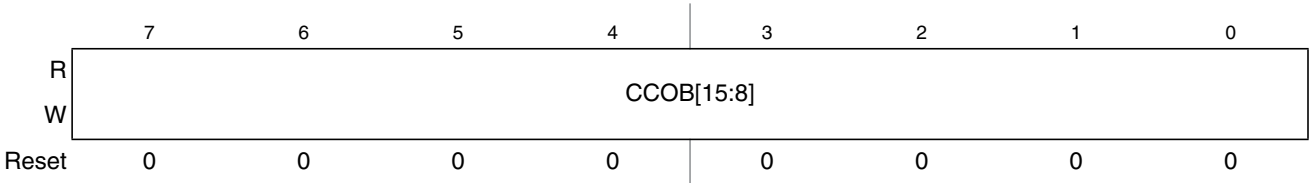


Figure 31-16. Flash Common Command Object High Register (FCCOBHI)

Offset Module Base + 0x000B

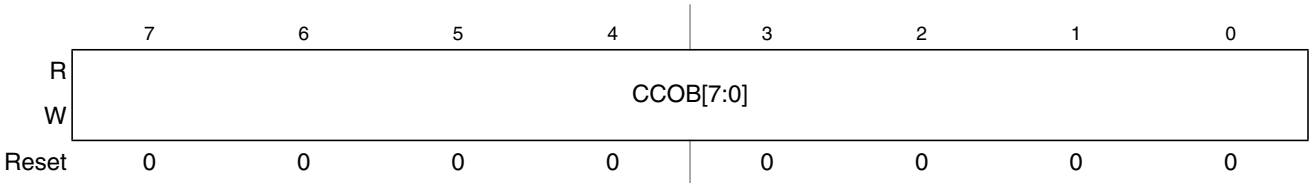


Figure 31-17. Flash Common Command Object Low Register (FCCOBLO)

31.3.2.11.1 FCCOB - NVM Command Mode

NVM command mode uses the indexed FCCOB register to provide a command code and its relevant parameters to the Memory Controller. The user first sets up all required FCCOB fields and then initiates the command's execution by writing a 1 to the CCIF bit in the FSTAT register (a 1 written by the user clears the CCIF command completion flag to 0). When the user clears the CCIF bit in the FSTAT register all FCCOB parameter fields are locked and cannot be changed by the user until the command completes (as evidenced by the Memory Controller returning CCIF to 1). Some commands return information to the FCCOB register array.

The generic format for the FCCOB parameter fields in NVM command mode is shown in Table 31-24. The return values are available for reading after the CCIF flag in the FSTAT register has been returned to 1 by the Memory Controller. Writes to the unimplemented parameter fields (CCOBIX = 110 and CCOBIX = 111) are ignored with reads from these fields returning 0x0000.

Table 31-24 shows the generic Flash command format. The high byte of the first word in the CCOB array contains the command code, followed by the parameters for this specific Flash command. For details on the FCCOB settings required by each command, see the Flash command descriptions in Section 31.4.6.

Table 31-24. FCCOB - NVM Command Mode (Typical Usage)

CCOBIX[2:0]	Byte	FCCOB Parameter Fields (NVM Command Mode)
000	HI	FCMD[7:0] defining Flash command
	LO	6'h0, Global address [17:16]
001	HI	Global address [15:8]
	LO	Global address [7:0]

Table 31-64. Erase EEPROM Sector Command FCCOB Requirements

CCOBIX[2:0]	FCCOB Parameters	
000	0x12	Global address [17:16] to identify EEPROM block
001	Global address [15:0] anywhere within the sector to be erased. See Section 31.1.2.2 for EEPROM sector size.	

Upon clearing CCIF to launch the Erase EEPROM Sector command, the Memory Controller will erase the selected Flash sector and verify that it is erased. The CCIF flag will set after the Erase EEPROM Sector operation has completed.

Table 31-65. Erase EEPROM Sector Command Error Handling

Register	Error Bit	Error Condition
FSTAT	ACCERR	Set if CCOBIX[2:0] != 001 at command launch
		Set if command not available in current mode (see Table 31-27)
		Set if an invalid global address [17:0] is supplied see Table 31-3)
		Set if a misaligned word address is supplied (global address [0] != 0)
	FPVIOL	Set if the selected area of the EEPROM memory is protected
	MGSTAT1	Set if any errors have been encountered during the verify operation
	MGSTAT0	Set if any non-correctable errors have been encountered during the verify operation

31.4.7 Interrupts

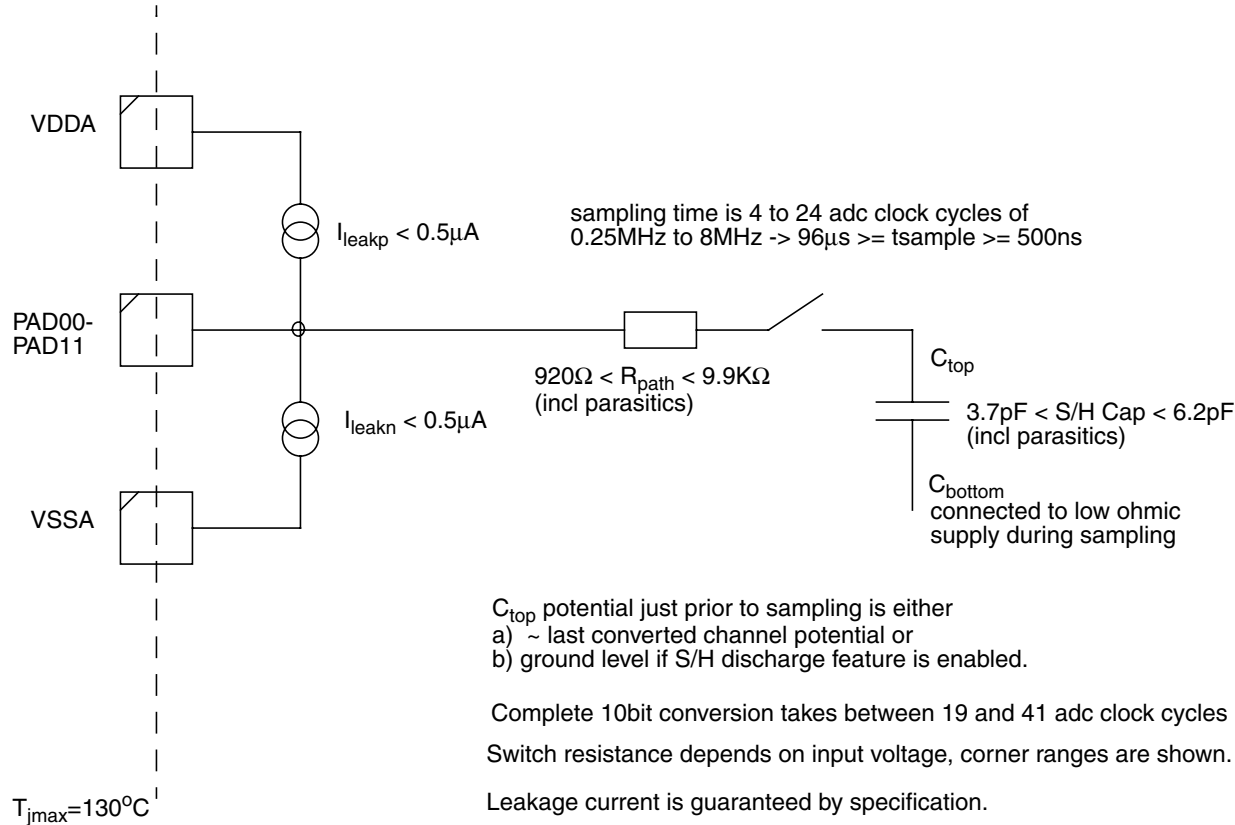
The Flash module can generate an interrupt when a Flash command operation has completed or when a Flash command operation has detected an ECC fault.

Table 31-66. Flash Interrupt Sources

Interrupt Source	Interrupt Flag	Local Enable	Global (CCR) Mask
Flash Command Complete	CCIF (FSTAT register)	CCIE (FCNFG register)	I Bit
ECC Double Bit Fault on Flash Read	DFDIF (FERSTAT register)	DFDIE (FERCNFG register)	I Bit
ECC Single Bit Fault on Flash Read	SFDIF (FERSTAT register)	SFDIE (FERCNFG register)	I Bit

A.4.3.2 ADC Analog Input Parasitics

Figure A-2. ADC Analog Input Parasitics



A.4.4 ADC Temperature Sensor

Table A-30. ADC Temperature Sensor

Num	C	Rating	Symbol	Min	Typ	Max	Unit
1	T	Temperature Sensor Slope	dV _{TS}	-4.0	-3.8	-3.6	mV/°C

A.5 ACMP Characteristics

This section describes the electrical characteristics of the analog comparator.